#### 查询SN74CB3Q16210DLR供应商

### 捷多邦,专业PCB打样工厂,24小时加SNT4CB3Q16210

20-BIT SWITCH 2.5-V/3.3-V LOW-VOLTAGE FET BUS SWITCH

SCDS166 - MAY 2004

•	Member of	the	Texas	Instruments
	Widebus™	Fam	nily	

- High-Bandwidth Data Path (Up To 500 MHz<sup>†</sup>)
- 5-V Tolerant I/Os with Device Powered Up or Powered Down
- Low and Flat ON-State Resistance (r<sub>on</sub>) Characteristics Over Operating Range (r<sub>on</sub> = 5 Ω Typical)
- Rail-to-Rail Switching on Data I/O Ports
   0-V to 5-V Switching With 3.3-V V<sub>CC</sub>
  - 0-V to 3.3-V Switching With 2.5-V V<sub>CC</sub>
- Bidirectional Data Flow, With Near-Zero Propagation Delay
- Low Input/Output Capacitance Minimizes Loading and Signal Distortion (C<sub>io(OFF)</sub> = 4 pF Typical)
- Fast Switching Frequency (f<sub>OE</sub> = 20 MHz Max)
- Data and Control Inputs Provide Undershoot Clamp Diodes
- Low Power Consumption (I<sub>CC</sub> = 1 mA Typical)
- V<sub>CC</sub> Operating Range From 2.3 V to 3.6 V
- Data I/Os Support 0 V to 5 V Signaling Levels (0.8 V, 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V, 5 V)
- Control Inputs Can be Driven by TTL or 5-V/3.3-V CMOS Outputs
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  2000-V Human-Body Model (A114-B, Class II)
  - 1000-V Charged-Device Model (C101)
- Supports Both Digital and Analog Applications: PCI Interface, Differential Signal Interface, Memory Interleaving, Bus Isolation, Low-Distortion Signal Gating

<sup>†</sup> For additional information regarding the performance characteristics of the CB3Q family, refer to the TI application report, *CBT-C, CB3T, and CB3Q Signal-Switch Families*, literature number SCDA008.

DGG, DGV, OR DL PACKAGE (TOP VIEW)						
NC [	1	U	48			
1A1	2		47	20E		
1A2	3		46	]1B1		
1A3 [	4		45	]1B2		
1A4 [	5		44	] 1B3		
1A5 [	6		43	]1B4		
1A6 [	7		42	] 1B5		
GND [	8		41	] GND		
1A7 [	9		40	]1B6		
1A8 [	10		39	]1B7		
1A9 [	11		38	]1B8		
1A10 🛛	12		37	]1B9		
2A1	13		36	]1B10		
2A2	14		35	]2B1		
V <sub>CC</sub>	15		34	]2B2		
2A3 [	16		33	]2B3		
GND [	17		32	] GND		
2A4 [	18		31	]2B4		
2A5 🛛	19		30	]2B5		
2A6 🛛	20		29	] 2B6		
2A7 🛛	21		28	] 2B7		
2A8 🛛	22		27	]2B8		
2A9 🛛	23		26	2B9		

NC - No internal connection

25

2B10

2A10

24



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#### description/ordering information

The SN74CB3Q16210 is a high-bandwidth FET bus switch utilizing a charge pump to elevate the gate voltage of the pass transistor, providing a low and flat ON-state resistance (ron). The low and flat ON-state resistance allows for minimal propagation delay and supports rail-to-rail switching on the data input/output (I/O) ports. The device also features low data I/O capacitance to minimize capacitive loading and signal distortion on the data bus. Specifically designed to support high-bandwidth applications, the SN74CB3Q16210 provides an optimized interface solution ideally suited for broadband communications, networking, and data-intensive computing systems.

The SN74CB3Q16210 is organized as two 10-bit bus switches with separate output-enable (10E, 20E) inputs. It can be used as two 10-bit bus switches or as one 20-bit bus switch. When OE is low, the associated 10-bit bus switch is ON and the A port is connected to the B port, allowing bidirectional data flow between ports. When OE is high, the associated 10-bit bus switch is OFF, and a high-impedance state exists between the A and B ports.

This device is fully specified for partial-power-down applications using Ioff. The Ioff circuitry prevents damaging current backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down, OE should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

TA	PACKAGET		ORDERABLE PART NUMBER	TOP-SIDE MARKING
		Tube	SN74CB3Q16210DL	00000000
4000 to 0500	SSOP – DL	Tape and reel	SN74CB3Q16210DLR	CB3Q16210
–40°C to 85°C	TSSOP – DGG	Tape and reel	SN74CB3Q16210DGGR	CB3Q16210
	TVSOP – DGV	Tape and reel	SN74CB3Q16210DGVR	BW210

#### ORDERING INFORMATION

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

(each 10-bit bus switch)					
	INPUT/OUTPUT A	FUNCTION			
L	В	A port = B port			

Disconnect

7

н

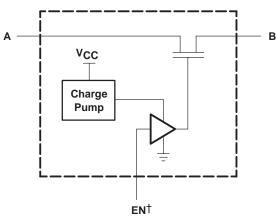
# FUNCTION TABLE



2 46 sw 1B1 1A1 ۲ • . • • 36 12 sw 1A10 1B10 48 1<mark>0E</mark> 35 13 2A1 sw 2B1 ٠ ۲ • • • • 25 24 2A10 sw 2B10 47 2<mark>0E</mark> -

logic diagram (positive logic)

simplified schematic, each FET switch (SW)



<sup>†</sup>EN is the internal enable signal applied to the switch.



SCDS166 - MAY 2004

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> (see Note 1)	–0.5 V to 4.6 V
Control input voltage range, V <sub>IN</sub> (see Notes 1 and 2)	
Switch I/O voltage range, VI/O (see Notes 1, 2, and 3)	
Control input clamp current, I <sub>IK</sub> (V <sub>IN</sub> < 0)	–50 mA
I/O port clamp current, I <sub>I/OK</sub> (V <sub>I/O</sub> < 0)	–50 mA
ON-state switch current, I <sub>I/O</sub> (see Note 4)	±64 mA
Continuous current through V <sub>CC</sub> or GND terminals	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 5): DGG package	70°C/W
DGV package	58°C/W
DL package	63°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltages are with respect to ground unless otherwise specified.
  - 2. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
  - 3. VI and VO are used to denote specific conditions for  $V_{I/O}$ .
  - 4. II and IO are used to denote specific conditions for  $I_{I/O}$ .
  - 5. The package thermal impedance is calculated in accordance with JESD 51-7.

### recommended operating conditions (see Note 6)

			MIN	MAX	UNIT
VCC	Supply voltage		2.3	3.6	V
V	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		1.7	5.5	V
VIH	High-level control input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2	5.5	V
	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	0	0.7	V	
VIL	Low-level control input voltage V <sub>CC</sub> = 2.7 V to 3.6 V		0	0.8	v
VI/O	Data input/output voltage		0	5.5	V
TA	Operating free-air temperature		-40	85	°C

NOTE 6: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



SCDS166 - MAY 2004

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITION	IS	MIN	TYP†	MAX	UNIT
VIK		V <sub>CC</sub> = 3.6 V,	I <sub>I</sub> = -18 mA				-1.8	V
I <sub>IN</sub>	Control inputs	V <sub>CC</sub> = 3.6 V,	V <sub>IN</sub> = 0 to 5.5 V				±1	μΑ
loz‡		V <sub>CC</sub> = 3.6 V,	$V_{O} = 0$ to 5.5 V, $V_{I} = 0$ ,	Switch OFF, V <sub>IN</sub> = V <sub>CC</sub> or GND			±1	μΑ
loff		$V_{CC} = 0,$	$V_{O} = 0$ to 5.5 V,	V <sub>I</sub> = 0			1	μΑ
ICC		V <sub>CC</sub> = 3.6 V,	I <sub>I/O</sub> = 0, Switch ON or OFF,	$V_{IN} = V_{CC}$ or GND		1	3	mA
∆lcc§	Control inputs	V <sub>CC</sub> = 3.6 V,	One input at 3 V,	Other inputs at $V_{CC}$ or GND			30	μΑ
ICCD	Per control input	V <sub>CC</sub> = 3.6 V,	A and B ports open, Control input switching at 50% duty cycle			0.15	0.25	mA/ MHz
C <sub>in</sub>	Control inputs	V <sub>CC</sub> = 3.3 V,	V <sub>IN</sub> = 5.5 V, 3.3 V, or	0		3.5	5	pF
C <sub>io(OFF</sub>	=)	V <sub>CC</sub> = 3.3 V,	Switch OFF, V <sub>IN</sub> = V <sub>CC</sub> or GND,	$V_{I/O} = 5.5 V, 3.3 V, \text{ or } 0$		4	5	pF
C <sub>io(ON)</sub>	)	V <sub>CC</sub> = 3.3 V,	Switch ON, V <sub>IN</sub> = V <sub>CC</sub> or GND,	V <sub>I/O</sub> = 5.5 V, 3.3 V, or 0		10	12.5	pF
r <sub>on</sub> #		V <sub>CC</sub> = 2.3 V,	$V_{I} = 0,$	I <sub>O</sub> = 30 mA		5	8	
		TYP at $V_{CC} = 2.5 V$	V <sub>I</sub> = 1.7 V,	I <sub>O</sub> = -15 mA		5	9	Ω
		V <sub>CC</sub> = 3 V	$V_{I} = 0,$	IO = 30 mA		5	7	52
		VCC = 3 V	V <sub>I</sub> = 2.4 V,	I <sub>O</sub> = -15 mA		5	9	1

NOTE 7:  $V_{IN}$  and  $I_{IN}$  refer to control inputs.  $V_I$ ,  $V_O$ ,  $I_I$ , and  $I_O$  refer to data pins.

<sup>†</sup> All typical values are at  $V_{CC}$  = 3.3 V (unless otherwise noted),  $T_A$  = 25°C.

 $\ddagger$  For I/O ports, the parameter  $I_{OZ}$  includes the input leakage current.

§ This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V<sub>CC</sub> or GND.

This parameter specifies the dynamic power-supply current associated with the operating frequency of a single control input (see Figure 2).

# Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

#### switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

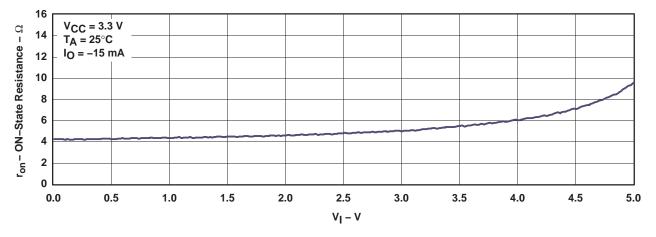
PARAMETER	FROM	TO	V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT
	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	
fOE	OE	A or B		10		20	MHz
<sup>t</sup> pd <sup>☆</sup>	A or B	B or A		0.15		0.25	ns
<sup>t</sup> en	OE	A or B	1.5	9	1.5	8	ns
<sup>t</sup> dis	OE	A or B	1	8	1	7	ns

I Maximum switching frequency for control input ( $V_{O} > V_{CC}$ ,  $V_{I} = 5 V$ ,  $R_{I} \ge 1 M\Omega$ ,  $C_{I} = 0$ )

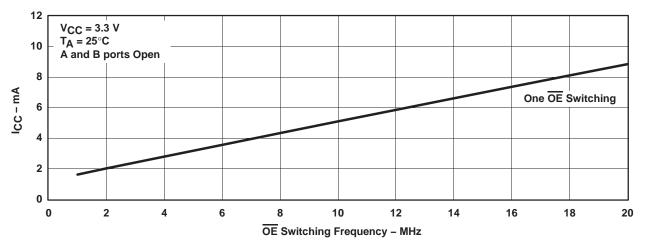
\* The propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).





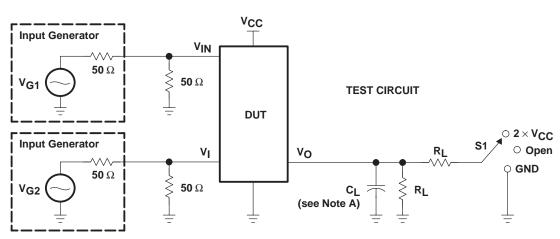






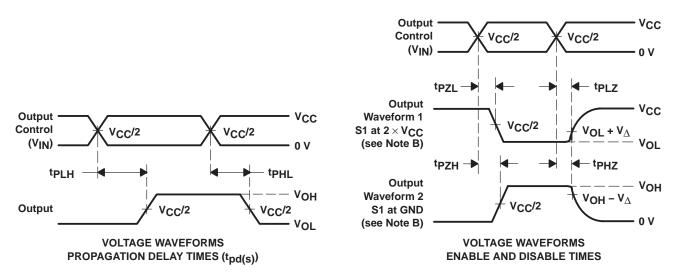


SCDS166 - MAY 2004



#### PARAMETER MEASUREMENT INFORMATION

TEST	V <sub>CC</sub>	S1	RL	٧I	сL	$v_\Delta$
<sup>t</sup> pd(s)	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	Open Open	<b>500</b> Ω <b>500</b> Ω	V <sub>CC</sub> or GND V <sub>CC</sub> or GND	30 pF 50 pF	
<sup>t</sup> PLZ <sup>/t</sup> PZL	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	$\begin{array}{c} 2 \times \mathbf{V}_{CC} \\ 2 \times \mathbf{V}_{CC} \end{array}$	<b>500</b> Ω <b>500</b> Ω	GND GND	30 pF 50 pF	0.15 V 0.3 V
<sup>t</sup> PHZ <sup>/t</sup> PZH	$\begin{array}{c} \textbf{2.5 V} \pm \textbf{0.2 V} \\ \textbf{3.3 V} \pm \textbf{0.3 V} \end{array}$	GND GND	<b>500</b> Ω <b>500</b> Ω	V <sub>CC</sub> V <sub>CC</sub>	30 pF 50 pF	0.15 V 0.3 V



- NOTES: A. CI includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns.
  - D. The outputs are measured one at a time, with one transition per measurement.
  - E. tpl 7 and tpH7 are the same as tdis.
  - F.  $t_{PZI}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G. tpLH and tpHL are the same as tpd(s). The tpd propagation delay is the calculated RC time constant of the typical ON-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).
  - H. All parameters and waveforms are not applicable to all devices.

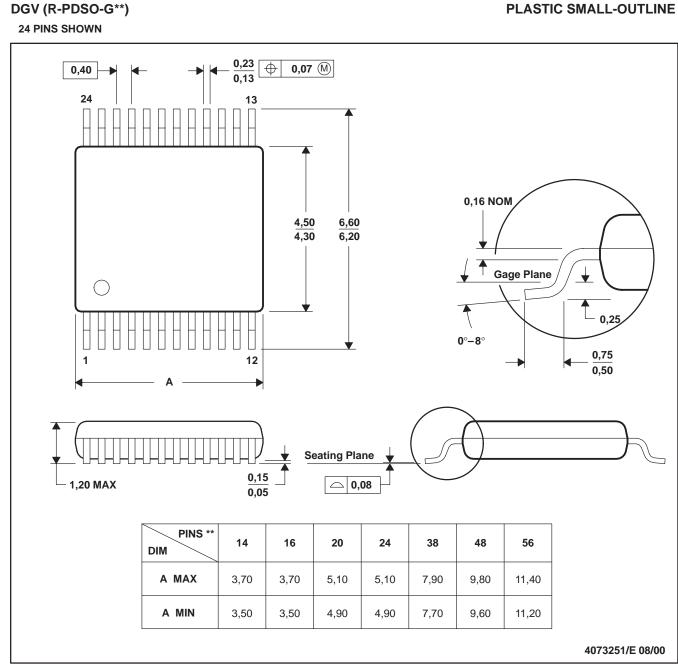
#### Figure 3. Test Circuit and Voltage Waveforms



### **MECHANICAL DATA**

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

#### PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153
  - 14/16/20/56 Pins MO-194

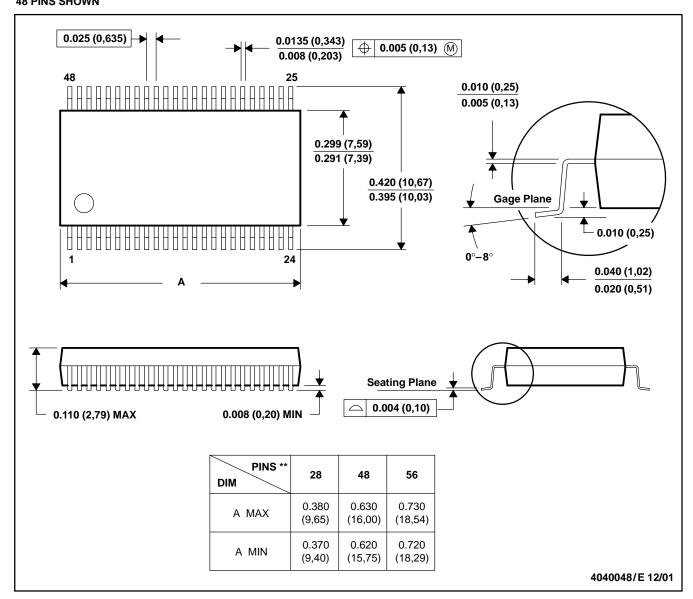


### **MECHANICAL DATA**

MSSO001C - JANUARY 1995 - REVISED DECEMBER 2001

#### PLASTIC SMALL-OUTLINE PACKAGE

### DL (R-PDSO-G\*\*) 48 PINS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

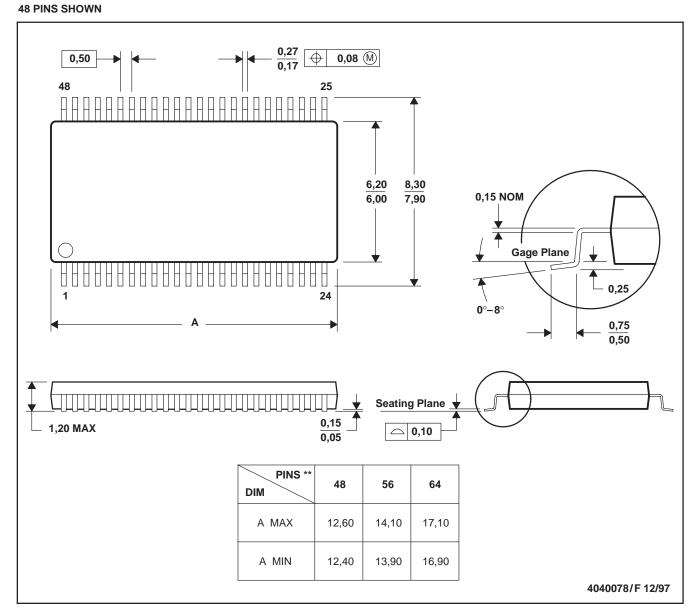


### **MECHANICAL DATA**

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

### PLASTIC SMALL-OUTLINE PACKAGE

DGG (R-PDSO-G\*\*)



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153



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